

FQA6N90C_F109

900V N-Channel MOSFET

Features

- 6A, 900V, $R_{DS(on)} = 2.3\Omega @ V_{GS} = 10V$
- Low gate charge (typical 30 nC)
- Low Crss (typical 11pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies, active power factor correction, electronic lamp ballast based on half bridge topology.



Absolute Maximum Ratings

| Symbol | Parameter | FQA6N90C_F109 | Units |
|----------------|---|---------------|---------------------|
| V_{DSS} | Drain-Source Voltage | 900 | V |
| I_D | Drain Current - Continuous ($T_C = 25^\circ\text{C}$) | 6.0 | A |
| | - Continuous ($T_C = 100^\circ\text{C}$) | 3.87 | A |
| I_{DM} | Drain Current - Pulsed (Note 1) | 24.0 | A |
| V_{GSS} | Gate-Source Voltage | ± 30 | V |
| E_{AS} | Single Pulsed Avalanche Energy (Note 2) | 650 | mJ |
| I_{AR} | Avalanche Current (Note 1) | 6.0 | A |
| E_{AR} | Repetitive Avalanche Energy (Note 1) | 19.8 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 4.0 | V/ns |
| P_D | Power Dissipation ($T_C = 25^\circ\text{C}$) | 198 | W |
| | - Derate above 25°C | 1.59 | W/ $^\circ\text{C}$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | $^\circ\text{C}$ |
| T_L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300 | $^\circ\text{C}$ |

Thermal Characteristics

| Symbol | Parameter | Typ | Max | Units |
|-----------------|---|------|------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | -- | 0.63 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink | 0.24 | -- | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | -- | 40 | $^\circ\text{C}/\text{W}$ |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|---------------|---------|-----------|------------|----------|
| FQA6N90C | FQA6N90C_F109 | TO-3PN | -- | -- | 30 |

Electrical Characteristics T_C = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|-----|------|------|-------|
| Off Characteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0 V, I _D = 250 μA | 900 | -- | -- | V |
| ΔBV _{DSS} /ΔT _J | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | -- | 1.07 | -- | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 900 V, V _{GS} = 0 V | -- | -- | 10 | μA |
| | | V _{DS} = 720 V, T _C = 125°C | -- | -- | 100 | μA |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | -- | -- | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | -- | -- | -100 | nA |
| On Characteristics | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = 250 μA | 3.0 | -- | 5.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D = 3.0 A | -- | 1.93 | 2.3 | Ω |
| g _{FS} | Forward Transconductance | V _{DS} = 50 V, I _D = 3.0 A (Note 4) | -- | 5.5 | -- | S |
| Dynamic Characteristics | | | | | | |
| C _{iss} | Input Capacitance | V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz | -- | 1360 | 1770 | pF |
| C _{oss} | Output Capacitance | | -- | 110 | 145 | pF |
| C _{rss} | Reverse Transfer Capacitance | | -- | 11 | 15 | pF |
| Switching Characteristics | | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 450 V, I _D = 6.0A, R _G = 25 Ω (Note 4, 5) | -- | 35 | 80 | ns |
| t _r | Turn-On Rise Time | | -- | 90 | 190 | ns |
| t _{d(off)} | Turn-Off Delay Time | | -- | 55 | 120 | ns |
| t _f | Turn-Off Fall Time | | -- | 60 | 130 | ns |
| Q _g | Total Gate Charge | V _{DS} = 720 V, I _D = 6.0A, V _{GS} = 10 V (Note 4, 5) | -- | 30 | 40 | nC |
| Q _{gs} | Gate-Source Charge | | -- | 9.0 | -- | nC |
| Q _{gd} | Gate-Drain Charge | | -- | 12 | -- | nC |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I _S | Maximum Continuous Drain-Source Diode Forward Current | | -- | -- | 6.0 | A |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | -- | -- | 24 | A |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 6.0 A | -- | -- | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 6.0 A, dI _F / dt = 100 A/μs (Note 4) | -- | 630 | -- | ns |
| Q _{rr} | Reverse Recovery Charge | | -- | 6.9 | -- | μC |

NOTES:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 34mH, I_{AS} = 6.0A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C
3. I_{SD} ≤ 6.0A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

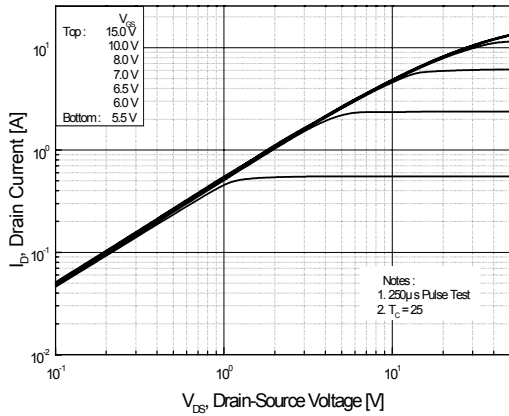


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

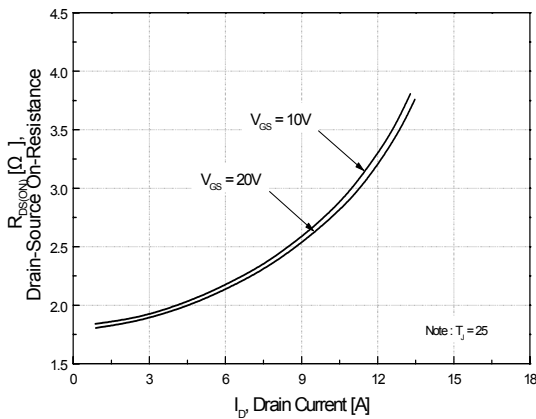


Figure 5. Capacitance Characteristics

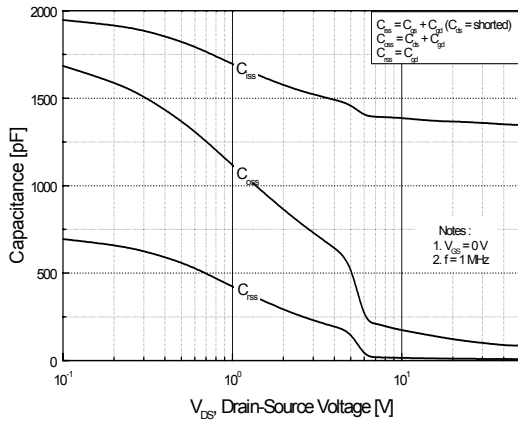


Figure 2. Transfer Characteristics

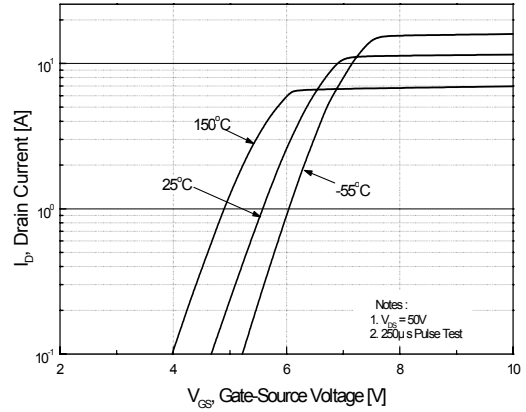


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

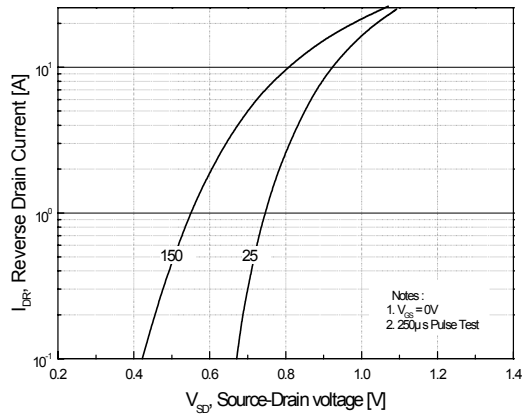
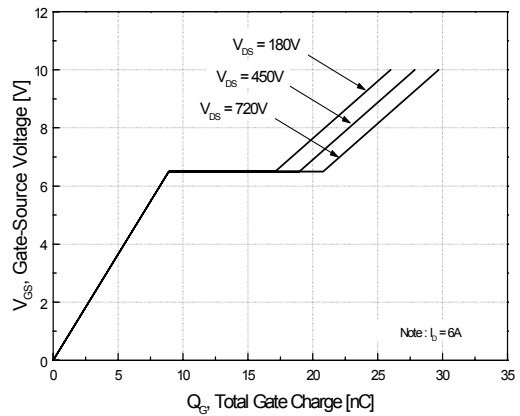


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

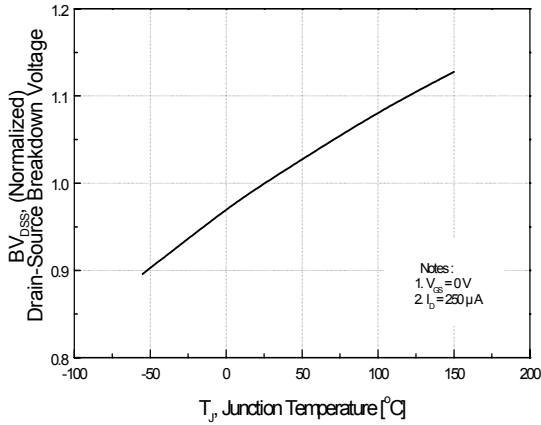


Figure 8. On-Resistance Variation vs. Temperature

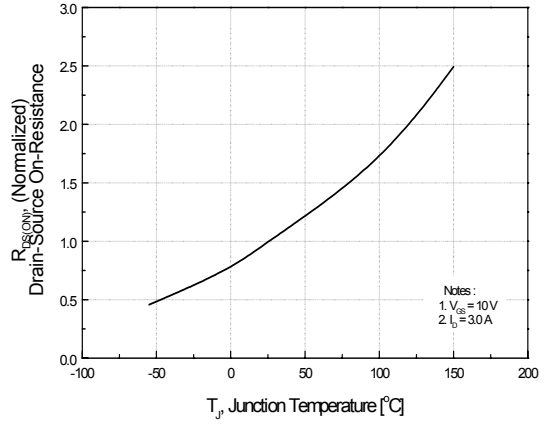


Figure 9. Maximum Safe Operating Area

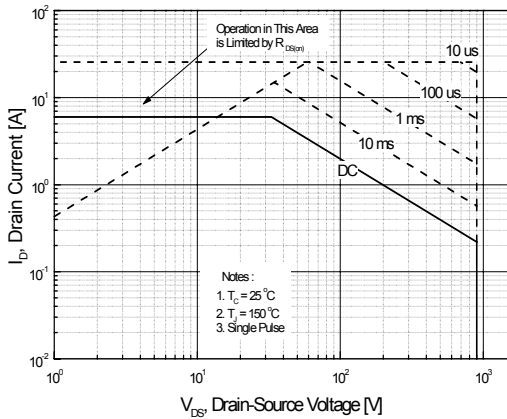


Figure 10. Maximum Drain Current vs. Case Temperature

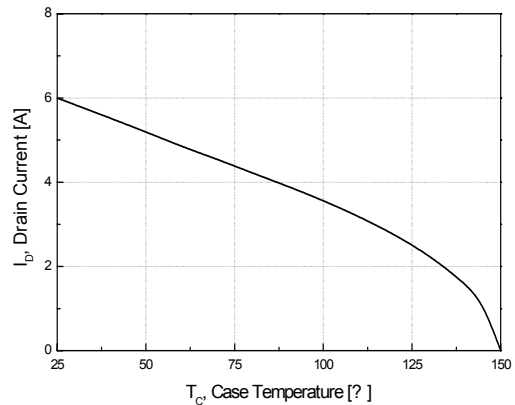
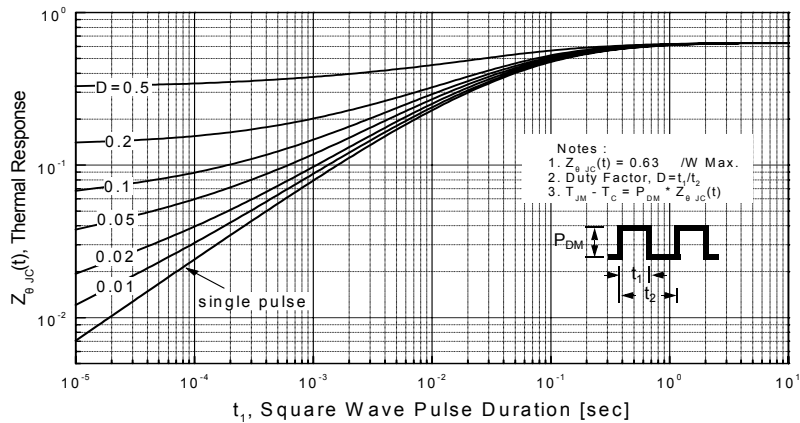


Figure 11. Transient Thermal Response Curve



Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

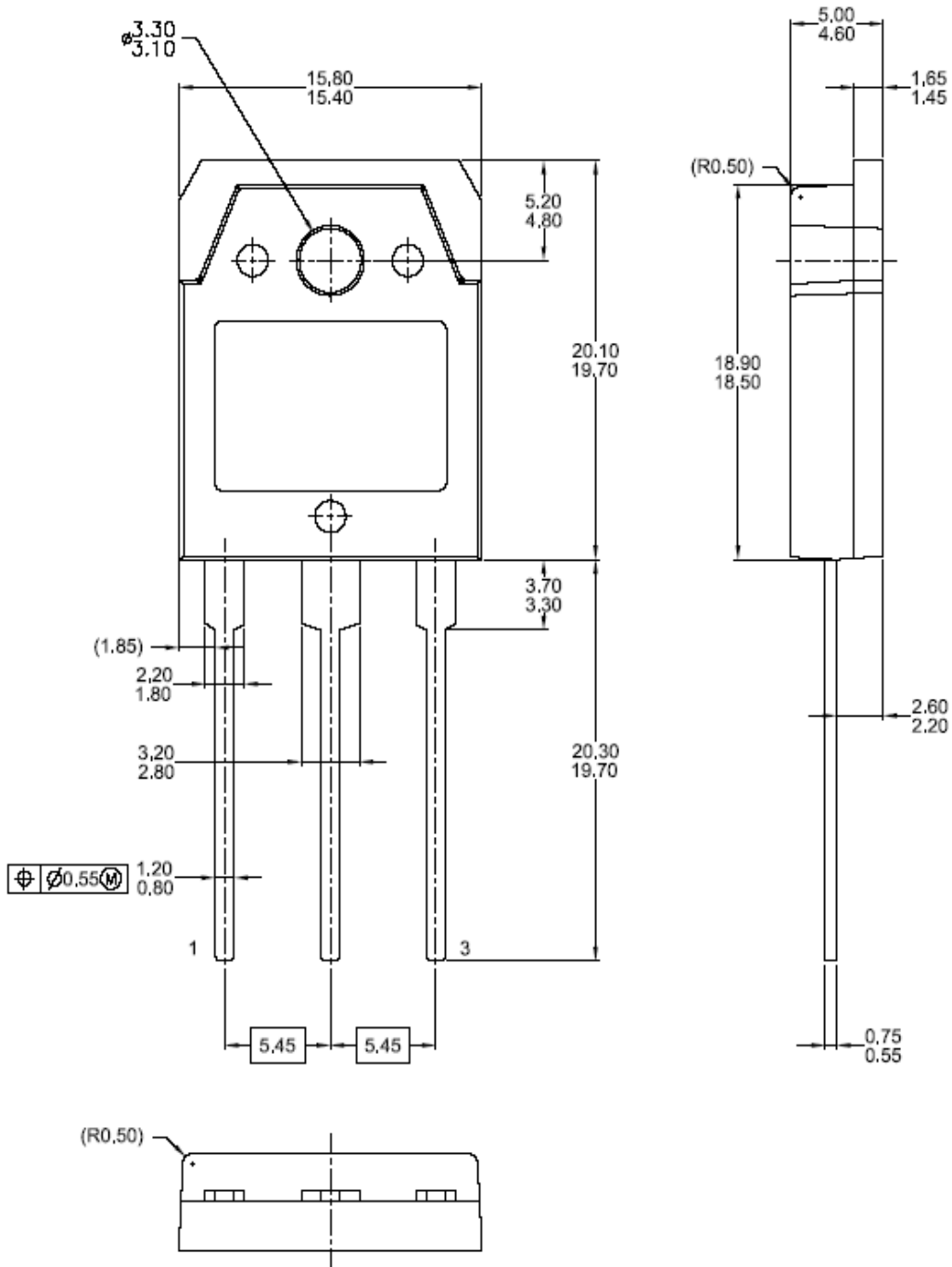


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Mechanical Dimensions

TO-3PN




Dimensions in Millimeters



TRADEMARKS

The following are registered and unregistered trademarks and service marks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

| | | | |
|--------------------------------------|--|--|----------------------------------|
| ACEx [®] | Green FPS [™] | Power247 [®] | SuperSOT [™] -8 |
| Build it Now [™] | Green FPS [™] e-Series [™] | POWEREDGE [®] | SyncFET [™] |
| CorePLUS [™] | GTO [™] | Power-SPM [™] | The Power Franchise [®] |
| CROSSVOLT [™] | <i>i-Lo</i> [™] | PowerTrench [®] | the power franchise |
| CTL [™] | IntelliMAX [™] | Programmable Active Droop [™] | TinyBoost [™] |
| Current Transfer Logic [™] | ISOPLANAR [™] | QFET [®] | TinyBuck [™] |
| EcoSPARK [®] | MegaBuck [™] | QS [™] | TinyLogic [®] |
| F [®] | MICROCOUPLER [™] | QT Optoelectronics [™] | TINYOPTO [™] |
| Fairchild [®] | MicroFET [™] | Quiet Series [™] | TinyPower [™] |
| Fairchild Semiconductor [®] | MicroPak [™] | RapidConfigure [™] | TinyPWM [™] |
| FACT Quiet Series [™] | MillerDrive [™] | SMART START [™] | TinyWire [™] |
| FACT [®] | Motion-SPM [™] | SPM [®] | μSerDes [™] |
| FAST [®] | OPTOLOGIC [®] | STEALTH [™] | UHC [®] |
| FastvCore [™] | OPTOPLANAR [®] | SuperFET [™] | UniFET [™] |
| FPS [™] |  [®] | SuperSOT [™] -3 | VCX [™] |
| FRFET [®] | PDP-SPM [™] | SuperSOT [™] -6 | |
| Global Power Resource SM | Power220 [®] | | |

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

| Datasheet Identification | Product Status | Definition |
|--------------------------|------------------------|--|
| Advance Information | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| No Identification Needed | Full Production | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| Obsolete | Not In Production | This datasheet contains specifications on a product that has been discontinued by Fairchild Semiconductor. The datasheet is printed for reference information only. |

Rev. I31

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Распределительные склады, находящиеся в России, Европе и в Китае, позволяют нам оперативно поставить необходимые компоненты в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям ISO 9001:2011

Офис по работе с юридическими лицами:

107023, г.Москва, Семеновский переулок, д.6, Бизнес-центр «АВС»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

| | |
|---------------|--------------|
| moschip.ru_3 | moschip.ru_6 |
| moschip.ru_4 | moschip.ru_7 |
| moschip.ru_11 | moschip.ru_8 |
| moschip.ru_12 | moschip.ru_9 |